PCN Number:			20221215006.1							PCN	N Date:	December 16, 2022		
Title	<b>:</b> :	of ATJ as Additional Chip on Chip process site for Select Package Dev					t Package Devices							
<b>Customer Contact:</b>			PCN	Manage	<u>r</u>	Dept:		Quality Se	rvice	es				
Proposed 1 <sup>st</sup> Ship Date			e:	Mar 16, 2023					Sample requests accepted until:  Jan 16, 2023*					
*Sa	mple re	equests receiv	ed a	fter (Ja	n 16	5, 2023)	wi	II not be su	ppor	ted.				
	nge T	ype:												
		mbly Site				Design					Wafer Bump Site			
$\boxtimes$		mbly Process	☐ Data S						Wafer Bump Material					
		mbly Materials					umber change				Wafer Bump Process			
<u> </u>		anical Specific				Test S		:e			Wafer Fab Site			
$\boxtimes$	Packi	ng/Shipping/L	abeling 🔲 Test P			roc	ocess			Wafer Fab Materials				
										Ш	Wafer Fab Process			
	PCN Details													
		on of Change												
(CoC sites	C) proc s and N		elect	device	liste	ed in the		•				al Chip on Chip urrent Chip on Chip		
Mat	eriai i	Jillerences.	ASE					ATJ						
	1ount (	Compound	Die attach film					Die attach	nast	Q				
	on C	hip Method:						ATJ CoC						
<b>†</b>			Bottom Die on Substrate					CoC bonding (Flux-less reflow)						
Die Attac			ch Film CoC bonding (Flux reflow)					CoC underfill  (Transport from ATJ to ASE)						
									L		Attach Pa			
_		CoC underfill					CoC on Substrate							
Sample Package Marking Differences:									1					
Device				ASE C				oC			ATJ Coc			
	DLPC7541ZDC  TEXAS INS  DLPC7541ZDC  T6WX5XBG-00  TAIWAN WWY  Lot Code				7541ZDC (5XBG-000 AN WWYY	2W1	P <sup>®</sup> MENTS		DLPC	AS INSTR 7541ZDC (5XBG-0002 IAN WWYYHoode	W1			

DLPC7540ZDC





# Reason for Change:

Continuity of supply.

Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):

None

### **Impact on Environmental Ratings:**

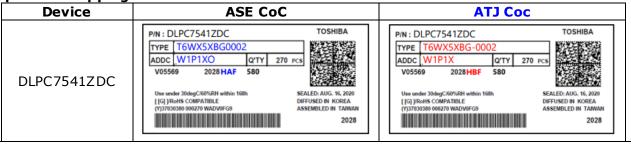
Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.

RoHS	REACH	Green Status	IEC 62474
☑ No Change	⊠ No Change	☑ No Change	☑ No Change

### Changes to product identification resulting from this PCN:

Sample TI shipping label Device **ASE CoC ATJ Coc** TEXAS INSTRUMENTS G1 TEXAS INSTRUMENTS (Pb) (44) G1 ☻ **0** MADE IN:TAIWAN DLPC7541ZDC 2DC: 2Q: (31T) LOT: 0V05733TEA (4W) TKY (1T)\$019765298 (L) TO: 2DC: 2Q: (31T) LOT: 0V05733TEA (4W) TKY (1T)\$019765298 2034HAF MSL 3/250C/168HR SEAL DT 09/14/20 MSL 3/250C/168HR SEAL DT TEXAS INSTRUMENTS G1 TEXAS INSTRUMENTS G1 ☻ • MADE IN:TAIWAN MADE IN:TAIWAN DLPC7540ZDC 2DC: 2Q: (31T) LOT: 0V05733TEA (4W) TKY (1T)\$019765298 (L) TO: 2DC: 2Q: (31T) LOT: 0V05733TEA (4W) TKY (1T)\$019765298 (L) TO: 2034HAF MSL 3/250C/168HR MSL 3/250C/168HR

Sample TSB shipping label



# **Qualification Report**

Approve Date 28-Jul-2022

## **Qualification Results**

Data Displayed as: Number of lots / Total sample size / Total failed

Items	Reference	Test Condition	Criteria	Test time/cycle	Sample size	Result
Preconditioning	JESD22-A113	Bake: 125degCx24H Moisture absorption: 30degC60%RHx216H Reflow: 250degCMax, 3Times	No failure	-	77pcs x 3LOT	Pass
TC (Thermal Cycle Test)	JESD22-A104	-55degC ~ 125degC with Preconditioning	No failure	700сус	25pcs x 3LOT	Pass
uHAST (Unbiased HAST)	JESD22-A118	110degC/85%RH with Preconditioning	No failure	264h	25pcs x 3LOT	Pass

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail					
WW PCN Team	PCN www admin_team@list.ti.com					

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